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## Strongly coupled C@SiO<sub>x</sub>/MoSe<sub>2</sub>@NMWCNT heterostructures as anodes for Na<sup>+</sup> batteries with excellent stability and capacity†

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Silicon and silicon oxide have become the most prospective anode materials, but the volume variations during charging and discharging have greatly hindered their practical applications. Herein, we constructed a highly ordered, dispersed silicon-molybdenum composite, C@SiO<sub>x</sub>/MoSe<sub>2</sub>@NMWCNT, with a three-layer heterojunction structure. In this approach, molybdenum pentachloride (MoCl<sub>5</sub>) reacts with ethylene glycol to form an ethylene glycol-based organomolybdenum complex, which then undergoes a reaction with triphenylchlorosilane, effectively bridging silicon and molybdenum to form an organometallic compound. After *in situ* selenization and carbonization, the formed SiO<sub>x</sub> is dispersed in the framework of MoSe<sub>2</sub> nanoflakes to form a SiO<sub>x</sub>/MoSe<sub>2</sub> composite structure. It is then adsorbed onto carbon nanotubes (NMWCNTs) with nitrogen-containing active sites, forming a three-layer heterojunction structure with the outer carbon layer. When used as a sodium-ion battery (SIB) anode, C@SiO<sub>x</sub>/MoSe<sub>2</sub>@NMWCNT exhibits an initial discharge-specific capacity (1315 mA h g<sup>-1</sup> at 0.1 A g<sup>-1</sup>) and a high capacity of 526 mA h g<sup>-1</sup> after 300 cycles at 0.5 A g<sup>-1</sup>, demonstrating excellent long-cycle stability. When the current density reaches 5 A g<sup>-1</sup>, the specific capacity remains at 415 mA h g<sup>-1</sup> after 1000 cycles and 353 mA h g<sup>-1</sup> after 3000 cycles. Even under a high current density of 10 A g<sup>-1</sup>, the material maintains remarkable cycling stability, delivering a capacity of 177.79 mA h g<sup>-1</sup> after 3000 cycles, illustrating the high potential of silicon for use in SIBs.

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## Introduction

Nowadays,<sup>1,2</sup> lithium-ion batteries (LIBs) are largely used for mobile electronics and electric-powered vehicles due to their excellent energy density.<sup>3,4</sup> However, owing to the relatively small spatial arrangement of lithium occurrences, it is necessary to explore alternatives for LIBs. SIBs are gaining traction owing to abundant availability and mechanisms analogous to those of LIBs.<sup>5–8</sup> Since Na<sup>+</sup> has a larger radius (1.06 Å)<sup>9</sup> compared to Li<sup>+</sup> (0.76 Å), the insertion and extraction kinetics of Na<sup>+</sup> are slower than those of Li<sup>+</sup>.<sup>10</sup> Thus, it is imperative to develop suitable anode materials for SIBs.

Silicon, which is abundant on Earth, has a theoretical specific capacity of approximately 4200 mA h g<sup>-1</sup>,<sup>11</sup> ten times that of conventional carbon anodes.<sup>12</sup> Coupled with their environmental friendliness, natural abundance, and low cost,<sup>13</sup> silicon-based materials (*e.g.*, Si, SiO<sub>x</sub>) are regarded as

promising anode materials for LIBs.<sup>14–16</sup> Researchers have developed several strategies to enhance the functionality of LIBs, such as nanomaterials,<sup>17,18</sup> structural engineering,<sup>19–21</sup> and composite materials.<sup>22–24</sup> Cao *et al.* created a Cu–Si nanoarray targeted at boosting the efficiency of LIBs,<sup>25</sup> Ma *et al.* successfully designed a conductive 3D porous silicon structure<sup>26</sup> to address the volume expansion problem caused by silicon during lithiation and delithiumization, and Zhong *et al.* invented a hollow Co/N-C@SiO<sub>2</sub> composite to optimize SiO<sub>2</sub> conductivity in LIBs.<sup>27</sup> However, most of these silicon materials used for LIBs are unsuitable for SIBs because Na<sup>+</sup>, with its larger radius, creates a relatively high diffusion barrier for sodium ions. Additionally, the larger volume expansion of silicon reduces battery performance.<sup>28–30</sup> To address these issues, methods such as designing nanostructured silicon, incorporating silicon into buffer matrices, designing silicon composite structures with conductive carbon materials, and doping of metallic elements have been recommended. Yao *et al.* successfully created Si/TiO<sub>2-x</sub>@C anode materials with porous structure for sodium-ion batteries by introducing Si into TiO<sub>2-x</sub>@C MOF structure acting as buffer layers, this MOF structure enhances the stability of the electrode in cycling operations, but Si does not exhibit its own high capacity due to the low conductivity of

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TiO<sub>2</sub> (190 mA h g<sup>-1</sup>@2 A g<sup>-1</sup>, 2500 cycles).<sup>28</sup> Ma *et al.* invented a new type of double-layer protective material Si@MnSe@PPyC/rGO for relieving volume changes for sodium-ion batteries, where nanopetaloidal MnSe serves as a buffer matrix wrapped around larger silicon particles and grows on the highly conductive PPyC/rGO carbon material, which can reduce the volume expansion of Si, but aggregation of silicon particles may occur during cycling, preventing silicon from consistently exhibiting a high capacity (226.4 mA h g<sup>-1</sup>@2 A g<sup>-1</sup>, 500 cycles).<sup>31</sup> Hirono *et al.* inserted conductive Sn into SiO<sub>x</sub> to form Sn/SiO<sub>x</sub> for improving sodium-ion batteries conductivity; although the electrical conductivity improved, the volume expansion of silicon led to poor cycling stability (340 mA h g<sup>-1</sup>@0.05 A g<sup>-1</sup>, 100 cycles).<sup>32</sup> Researchers have done a lot of work, but the results are still unsatisfactory,<sup>33</sup> as the issues of large volume expansion of silicon and the high diffusion energy barrier of Na<sup>+</sup> due to its larger radius have not been simultaneously addressed.

With the above challenge in mind, we designed to address these issues by uniformly dispersing SiO<sub>x</sub> on MoSe<sub>2</sub> nanosheets to form a SiO<sub>x</sub>/MoSe<sub>2</sub> composite structure. As we know, the layered molybdenum-based compounds have been disclosed as natural channels for the diffusion of Na<sup>+</sup>,<sup>34</sup> especially MoSe<sub>2</sub>, the interlayer distance of 0.66 nm is greater than that of which is 0.62 nm.<sup>35–37</sup> Therefore, MoSe<sub>2</sub> can suppress the aggregation of SiO<sub>x</sub> particles to improve dispersion, act as a stabilizing layer to reduce volume variations, and provide diffusion channels for sodium ions by reducing the energy barrier of sodium ions. For composite preparation, carbon nanotubes (CNTs) with unique flexibility,<sup>38,39</sup> high chemical stability and electrical conductivity are usually used as a template,<sup>40</sup> which not only allows the electrolyte to penetrate widely to improve its electronic and ionic conductivity but also adapts to volume changes in composites. In addition, by introducing functional groups featuring nitrogen (like pyridine-N, pyrrole-N, graphite-N, and pyridine-oxide-N) as active sites on CNTs,<sup>41–43</sup> SiO<sub>x</sub>/MoSe<sub>2</sub> can be further adsorbed on the active sites of nitrogen (N)-doped carbon nanotubes (NMWCNT) to form a three-layered heterojunction structure, which may prevent detachment from the electrode and enhance conductivity.

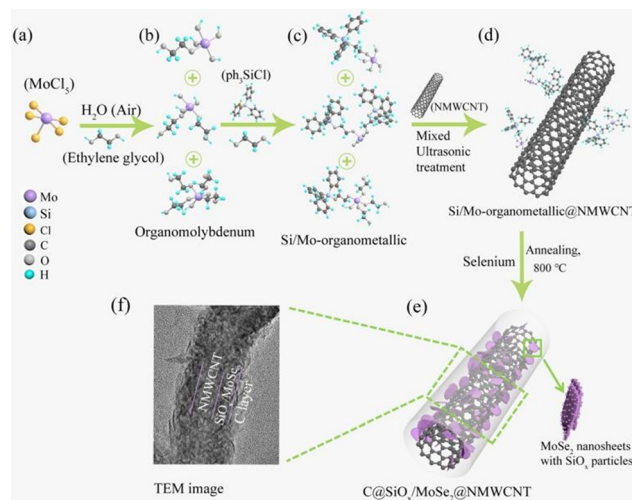
In this study, we constructed a highly ordered, dispersed silicon-molybdenum composite of C@SiO<sub>x</sub>/MoSe<sub>2</sub>@NMWCNT with a three-layer heterojunction structure. The outermost carbon layer obtained by carbonizing organic matter and NMWCNT forms a protective interlayer in which SiO<sub>x</sub>/MoSe<sub>2</sub> grows. It not only prevents the buildup of a thick SEI film but also mitigates volume expansion caused by the entry and extraction of Na<sup>+</sup>. This method not only enhances the capacity of batteries (526 mA h g<sup>-1</sup>@0.5 mA g<sup>-1</sup>, 300 cycles) but also improves their cycling stability for SIBs (415 mA h g<sup>-1</sup>, 353 mA h g<sup>-1</sup>@5 A g<sup>-1</sup>, 1000 cycles and 3000 cycles). Therefore, the C@SiO<sub>x</sub>/MoSe<sub>2</sub>@NMWCNT composite, with its three-layer heterostructure, shows great promise as an anode material for SIBs due to its synergistic advantages: the carbon layer ensures structural stability and conductivity, the SiO<sub>x</sub> provides high capacity and cycling stability, and the MoSe<sub>2</sub>

layer facilitates efficient sodium-ion diffusion. Combined with the mechanical strength and enhanced conductivity of NMWCNTs, this composite addresses key challenges such as volume expansion and low conductivity, making it a strong candidate for high-performance SIB applications.

## Results and discussion

As illustrated in Fig. 1, we reacted molybdenum pentachloride (MoCl<sub>5</sub>) with ethylene glycol to form an ethylene glycol-based organomolybdenum complex *via* ultrasonic treatment, followed by a reaction with triphenylchlorosilane *via* further ultrasonic treatment to form an organometallic compound. This indicates that Mo–Si organometallic compounds were formed successfully in high-resolution mass spectra (Fig. S1–S4†). Then, after *in situ* selenization and carbonization at 800 °C, the anode material C@SiO<sub>x</sub>/MoSe<sub>2</sub>@NMWCNT was successfully obtained. Within the same method, we successfully prepared C@MoSe<sub>2</sub>, C@SiO<sub>x</sub>@NMWCNT and C@SiO<sub>x</sub>/MoSe<sub>2</sub>@C composites through ultrasound and calcination (see Experimental section).

The structures of C@MoSe<sub>2</sub>, C@SiO<sub>x</sub>@NMWCNT, C@SiO<sub>x</sub>/MoSe<sub>2</sub>@C, and C@SiO<sub>x</sub>/MoSe<sub>2</sub>@NMWCNT were characterized using SEM and TEM. In previous studies,<sup>44</sup> we can see that C@MoSe<sub>2</sub> has a sheet-like structure and is intertwined with each other to create a 3D flower-like structure. The MoSe<sub>2</sub> nanosheets were verified to be coated with a carbon layer. Fig. S5 and S6† show that the carbon-coated SiO<sub>x</sub> grows on NMWCNTs to form a three-layer heterojunction composite C@SiO<sub>x</sub>@NMWCNT, and the adsorption of C@SiO<sub>x</sub> has almost no effect on the



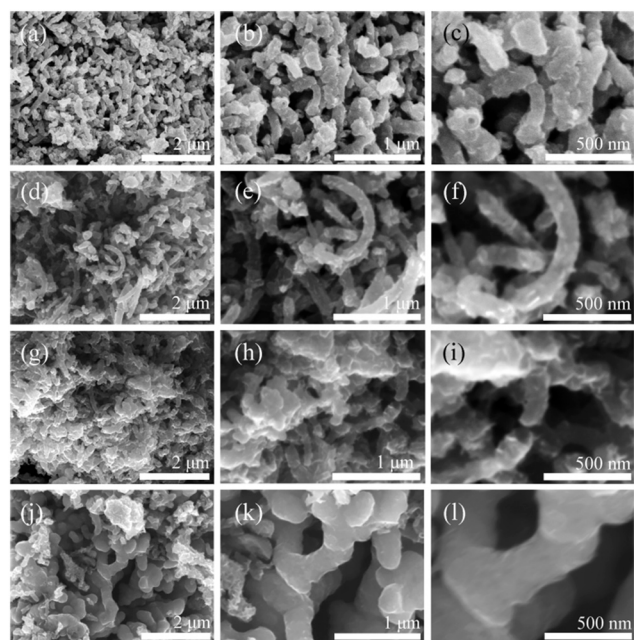
**Fig. 1** Preparation process of C@SiO<sub>x</sub>/MoSe<sub>2</sub>@NMWCNT, (a) MoCl<sub>5</sub> mixed with ethylene glycol to form organomolybdenum complexes by ultrasonic treatment; (b) organomolybdenum complexes mixed with ph<sub>3</sub>SiCl and ethylene glycol to form Si/Mo-organometallic by ultrasonic treatment; (c) Si/Mo-organometallic mixed with NMWCNT to form Si/Mo-organometallic@NMWCNT by ultrasonic treatment; (d) composite C@SiO<sub>x</sub>/MoSe<sub>2</sub>@NMWCNT obtained by *in situ* selenization at 800 °C; (e) C@SiO<sub>x</sub>/MoSe<sub>2</sub>@NMWCNT with three-layer structure; (f) TEM image of C@SiO<sub>x</sub>/MoSe<sub>2</sub>@NMWCNT.



morphology of the NMWCNTs. From the EDS element analysis in Fig. S6(d–g),† we can see four elements: C, Si, O, and N, where the Si and O elements gather to confirm the formation of  $\text{SiO}_x$  and also provide an idea for the subsequent addition of  $\text{MoSe}_2$  to act as a skeleton for dispersing  $\text{SiO}_x$ .

As shown in Fig. S7 and S8,† many  $\text{MoSe}_2$  nanosheets are formed in  $\text{C@SiO}_x/\text{MoSe}_2@\text{C}$  materials, and the formation of  $\text{SiO}_x$  and  $\text{MoSe}_2$  can be seen according to the TEM electron image and EDS element analysis in Fig. S8(c–i),† and the homogeneous dispersion of Mo, Se, C, O, and Si elements also indicates that  $\text{SiO}_x$  is uniformly dispersed on the  $\text{MoSe}_2$  nanosheets, and the organic components acted as carbon sources to form a carbon coating.

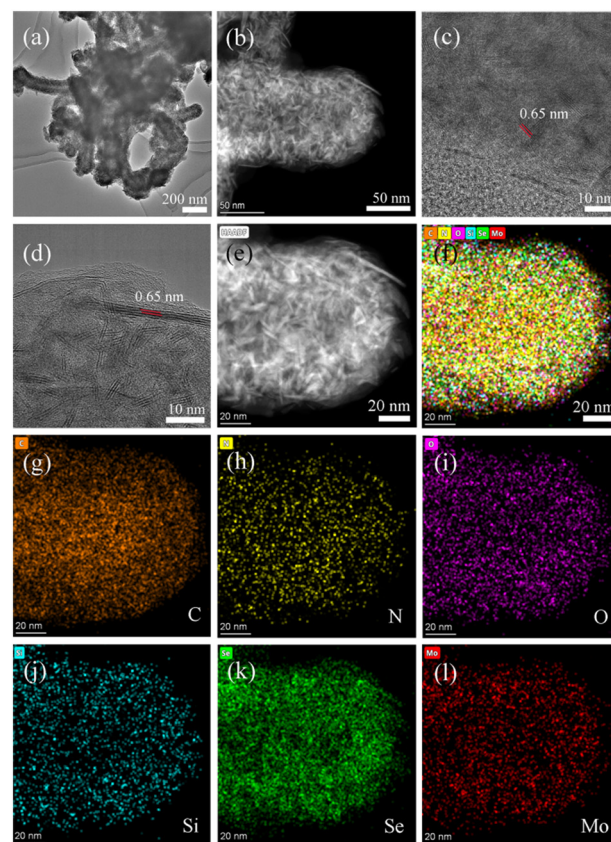
Fig. 2 shows the SEM image of  $\text{C@SiO}_x/\text{MoSe}_2@\text{NMWCNT}$ , in which (a–c)  $\text{SiO}_x/\text{MoSe}_2 = 2:1$ , (d–f)  $\text{SiO}_x/\text{MoSe}_2 = 3:1$ , (g–i)  $\text{SiO}_x/\text{MoSe}_2 = 4:1$  and (j–l)  $\text{SiO}_x/\text{MoSe}_2 = 5:1$ . Comparing the above four sets of plots, with the increase in the  $\text{SiO}_x$  ratio, the morphology of the NMWCNT changes a little. As shown in Fig. 2(g–l), the surface of the NMWCNTs is somewhat deformed, and the pipe walls become very thick, which hinders the transport of sodium ions and decreases their mobility. Compared with Fig. 2(g–l), the carbon nanotube skeletons in Fig. 2(a–f) are almost not affected, especially in Fig. 2(d–f), some  $\text{MoSe}_2$  nanosheets can be seen growing on the NMWCNT like fish scales, and some like leaves, which can boost the contact area for the active substance and electrolyte while also offering an improved channel for sodium ions to enter. Sodium-ion mobility and active material utilization efficiency are enhanced. Therefore, we selected  $\text{SiO}_x/\text{MoSe}_2 = 3:1$  as the best ratio.



**Fig. 2** SEM images of (a–c)  $\text{C@SiO}_x/\text{MoSe}_2-2:1@\text{NMWCNT}$ , (d–f)  $\text{C@SiO}_x/\text{MoSe}_2-3:1@\text{NMWCNT}$ , (g–i)  $\text{C@SiO}_x/\text{MoSe}_2-4:1@\text{NMWCNT}$  and (j–l)  $\text{C@SiO}_x/\text{MoSe}_2-5:1@\text{NMWCNT}$ .

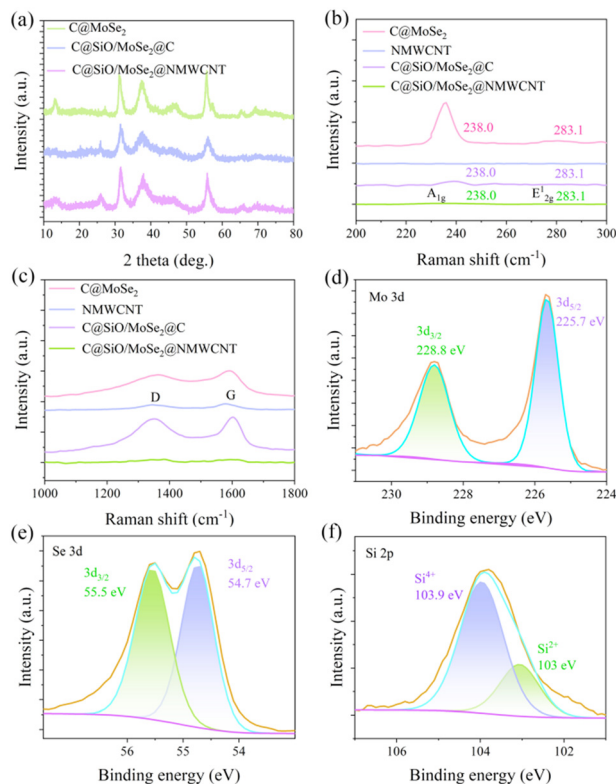
The HAADF-STEM images of  $\text{C@SiO}_x/\text{MoSe}_2-3:1@\text{NMWCNT}$  can also be seen that the leaf-like  $\text{MoSe}_2$  nanosheets are grown at an angle on the NMWCNT (Fig. 3b), and the EDS element analysis of Fig. 3(e–l) indicates the uniform distribution of elements (C, N, O, Si, Se, Mo), which also shows that  $\text{SiO}_x$  particles are evenly dispersed on  $\text{MoSe}_2$  nanosheets, which provides a high-capacity potential for the composite during charging and discharging. The lattice layer spacing in both HR-TEM Fig. 3c and d is approximately 0.65 nm, which matches the (002) plane of  $\text{MoSe}_2$ , which also proves that a large number of  $\text{MoSe}_2$  nanosheets have been formed, which offers a good channel for the embedding of  $\text{Na}^+$ , probably improves the storage capacity of sodium ions, and also plays a role in dispersing and storing silicon, upgrading the battery's capabilities.

To further authenticate the properties of the synthetic materials, XRD, Raman, and XPS analyses were conducted. Fig. 4a shows the XRD images of  $\text{C@MoSe}_2$ ,  $\text{C@SiO}_x/\text{MoSe}_2@\text{C}$  and  $\text{C@SiO}_x/\text{MoSe}_2-3:1@\text{NMWCNT}$  from 10 to 80 ( $2\theta$ ). The peaks at  $26.2^\circ$  for  $\text{C@SiO}_x/\text{MoSe}_2@\text{C}$  and  $\text{C@SiO}_x/\text{MoSe}_2-3:1@\text{NMWCNT}$  correspond to the (011) plane of  $\text{SiO}_2$  (JCPDS 47-1144), and the peaks at  $47^\circ$  and  $56^\circ$  correspond to  $\text{SiO}$  (JCPDS 30-1127). With the exception of



**Fig. 3** (a and b) TEM images of  $\text{C@SiO}_x/\text{MoSe}_2-3:1@\text{NMWCNT}$ , (c and d) HRTEM images of  $\text{C@SiO}_x/\text{MoSe}_2-3:1@\text{NMWCNT}$ , (e) STEM images of  $\text{C@SiO}_x/\text{MoSe}_2-3:1@\text{NMWCNT}$ , (f) elemental distribution of  $\text{C@SiO}_x/\text{MoSe}_2-3:1@\text{NMWCNT}$  and corresponding (g)–(l) EDS-mapping element maps.





**Fig. 4** (a) XRD patterns of C@MoSe<sub>2</sub>, C@SiO<sub>x</sub>/MoSe<sub>2</sub>@C, C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT, (b and c) Raman spectra of C@MoSe<sub>2</sub>, NMWCNT, C@SiO<sub>x</sub>/MoSe<sub>2</sub>@C, C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT, and high-resolution XPS (d) Mo 3d spectrum, (e) Se 3d spectrum, (f) Si 2p spectrum of C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT.

these peaks, the other peaks correspond to the MoSe<sub>2</sub> (JCPDS 29-0914) peak group, indicating the significant formation of MoSe<sub>2</sub>. Fig. 4b, S9a† and 4c show the Raman spectra for C@MoSe<sub>2</sub>, NMWCNT, C@SiO<sub>x</sub>/MoSe<sub>2</sub>@C, and C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT, as shown in Fig. 4b, where 238.0 cm<sup>-1</sup> represents the out-of-plane atomic vibration mode (*A*<sub>1g</sub>) of MoSe, and 283.1 cm<sup>-1</sup> represents the in-plane atomic vibration mode (*E*<sub>2g</sub><sup>1</sup>) of MoSe. The strength ratios of C@MoSe<sub>2</sub> (12.29), C@SiO<sub>x</sub>/MoSe<sub>2</sub>@C (1.08) and C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT (1.19) from *A*<sub>1g</sub> to *E*<sub>2g</sub><sup>1</sup> are quite different, indicating that SiO<sub>x</sub> has a certain influence on the layered structure of MoSe<sub>2</sub>, and confirms that SiO<sub>x</sub> is successfully inserted and attached to the layered structure of MoSe<sub>2</sub> to form SiO<sub>x</sub>/MoSe<sub>2</sub> composites. The results also suggest a powerful interaction between NMWCNTs and SiO<sub>x</sub>/MoSe<sub>2</sub>. In Fig. 4c, the Raman images for C@MoSe<sub>2</sub>, NMWCNT, C@SiO<sub>x</sub>/MoSe<sub>2</sub>@C and C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT show that the two peaks at 1352 cm<sup>-1</sup> and 1586 cm<sup>-1</sup> are the D and G segments of NMWCNT,<sup>37</sup> and the D/G respectively matches to C@MoSe<sub>2</sub> (0.91), NMWCNT (1.0), C@SiO<sub>x</sub>/MoSe<sub>2</sub>@C (0.96) and C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT (0.92). The strength ratios are almost identical, proving that they have similar degrees of defect.<sup>38</sup>

XPS was used to analyze the elemental composition and oxidation states at the surface of the C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:

1@NMWCNT composites. The O, Mo, N, C, Se and Si signals can be observed in the full spectrum (Fig. S9b†). In the Mo 3d spectrum (Fig. 4d), the Mo 3d<sub>3/2</sub> signal is observed at 228.8 eV, and the Mo 3d<sub>5/2</sub> signal is observed at 225.7 eV, indicating the state of Mo<sup>4+</sup>. In Fig. 4e (Se 3d spectrum), the Se 3d<sub>3/2</sub> signal is observed at 55.5 eV, and the Se 3d<sub>5/2</sub> signal is observed at 54.7 eV, indicating the state of Se<sup>2+</sup>. In the Si 2p spectrum (Fig. 4f), the signals at 103.9 eV and 103 eV correspond to tetravalent and divalent silicon, respectively, confirming the formation of SiO<sub>2</sub> and SiO. In Fig. S9d† (N 1s spectrum), there are three main peaks, which are 401.1 eV, 399.3 eV, and 395.1 eV, matching graphitic-N, pyrrolic-N and pyridinic-N.<sup>45</sup> In Fig. S9c† (C 1s spectrum), there are four main peaks at 288.8 eV, 286.8 eV, 285.6 eV and 284.8 eV, respectively named C=O, C-O, C-N and C-C bonds.

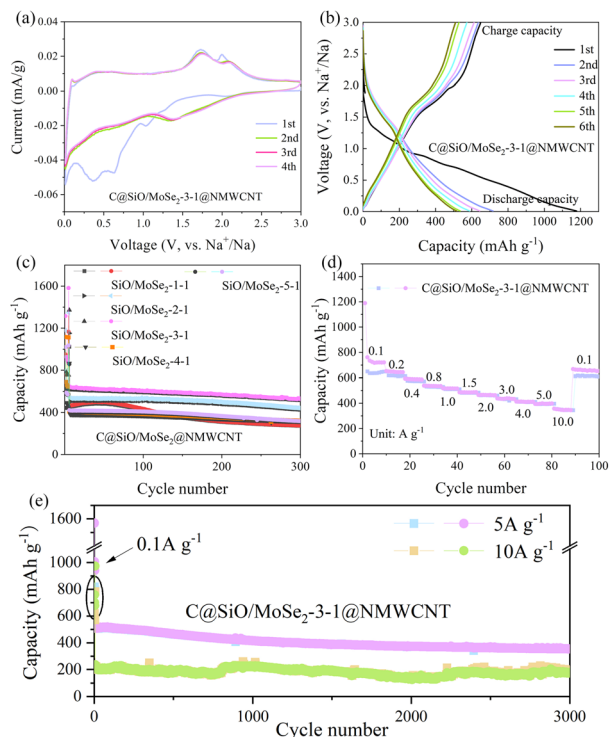
The MoSe<sub>2</sub> and SiO<sub>x</sub> contents in C@MoSe<sub>2</sub>, C@MoSe<sub>2</sub>@NMWCNT and C@SiO<sub>x</sub>/MoSe<sub>2</sub> (2/3/4:1)@NMWCNT were determined by thermogravimetric analysis (TGA) (Fig. S10†). When heated in air, SiO<sub>x</sub> is completely converted to SiO<sub>2</sub>, and its weight changes negligibly, and MoSe<sub>2</sub> oxidizes to form MoO<sub>3</sub> and SeO<sub>2</sub> before 350 °C; therefore, there is a phenomenon of weight increase. Thereafter, there will be two phases of weight loss. The first stage of weight reduction is due to SeO<sub>2</sub> sublimation, and the second stage of weight reduction is due to carbon oxidation. At temperatures of 900–1000 °C, the residues of C@MoSe<sub>2</sub> and C@MoSe<sub>2</sub>@NMWCNT were only 2.2% and 3.5%. The products of C@MoSe<sub>2</sub> and C@MoSe<sub>2</sub>@NMWCNT calcined at 900 °C for 4 h were detected by SEM (Fig. S11†) and TEM (Fig. S12 and S13†), and the results indicated that the product was predominantly MoO<sub>3</sub> encapsulated within the C-O-Mo frame (MoO<sub>3</sub> accounted for 99.47% of the product composition in Fig. S12e†).

Combined with the conservation principle applied to the Mo element, the proportion of MoSe<sub>2</sub> can be calculated using eqn (1).

$$M_{\text{MoSe}_2}\% = \frac{M_{\text{MoSe}_2}}{M_{\text{MoO}_3}} \times M_{\text{MoO}_3}\% \quad (1)$$

where *M*<sub>MoSe<sub>2</sub></sub> and *M*<sub>MoO<sub>3</sub></sub> represent the molecular weights of MoSe<sub>2</sub> and MoO<sub>3</sub>, *M*<sub>MoSe<sub>2</sub></sub>% and *M*<sub>MoO<sub>3</sub></sub>% are the masses of MoSe<sub>2</sub> and MoO<sub>3</sub> in the system (400–600 °C), respectively. Specifically, *M*<sub>MoSe<sub>2</sub></sub> = 253.86, *M*<sub>MoO<sub>3</sub></sub> = 143.94, the *M*<sub>MoO<sub>3</sub></sub>% of C@MoSe<sub>2</sub>, C@MoSe<sub>2</sub>@NMWCNT, C@SiO<sub>x</sub>/MoSe<sub>2</sub>-2:1@NMWCNT, C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT, and C@SiO<sub>x</sub>/MoSe<sub>2</sub>-4:1@NMWCNT are 53.1%, 30.4%, 30.9%, 25.2%, and 23.9%, respectively. The MoSe<sub>2</sub> contents in C@MoSe<sub>2</sub>, C@MoSe<sub>2</sub>@NMWCNT, C@SiO<sub>x</sub>/MoSe<sub>2</sub>-2:1@NMWCNT, C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT and C@SiO<sub>x</sub>/MoSe<sub>2</sub>-4:1@NMWCNT were calculated to be 93.6%, 53.6%, 54.5%, 44.4% and 42.2%, respectively. The SiO<sub>x</sub> contents in C@SiO<sub>x</sub>/MoSe<sub>2</sub>-2:1@NMWCNT, C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT, and C@SiO<sub>x</sub>/MoSe<sub>2</sub>-4:1@NMWCNT were 2.5%, 14%, and 19.2%, respectively.





**Fig. 5** (a) CV curves at a scan rate of  $0.1 \text{ mV s}^{-1}$ , (b) galvanostatic discharge and charge voltage curves ( $0.1 \text{ A g}^{-1}$ ) of  $\text{C@SiO}_x/\text{MoSe}_2\text{-}3:1\text{@NMWCNT}$ , (c) discharge and charge profiles ( $0.5 \text{ A g}^{-1}$ ) of  $\text{C@SiO}_x/\text{MoSe}_2\text{-}1/2/3/4/5:1\text{@NMWCNT}$ , (d) rate capacity of  $\text{C@SiO}_x/\text{MoSe}_2\text{-}3:1\text{@NMWCNT}$ , (e) long-term tests ( $5 \text{ A g}^{-1}$ ,  $10 \text{ A g}^{-1}$ ) of  $\text{C@SiO}_x/\text{MoSe}_2\text{-}3:1\text{@NMWCNT}$ .

Next, we tested the energy storage performance of the SIBs of four materials (Fig. 5):  $\text{C@MoSe}_2$ ,  $\text{C@SiO}_x\text{@NMWCNT}$ ,  $\text{C@SiO}_x/\text{MoSe}_2\text{@C}$ , and  $\text{C@SiO}_x/\text{MoSe}_2\text{-}3:1\text{@NMWCNT}$  by making button batteries. Fig. 5a shows the cyclic voltammetry (CV) curve of the  $\text{C@SiO}_x/\text{MoSe}_2\text{-}3:1\text{@NMWCNT}$  composite as an SIB electrode. In the initial cyclic voltammetry (CV) scan, three cathodic peaks were noted at  $1.03 \text{ V}$ ,  $0.63 \text{ V}$ , and  $0.36 \text{ V}$ . The peak ( $1.03 \text{ V}$ ) represents the process by which  $\text{Na}^+$  is inserted into  $\text{MoSe}_2$  to form  $\text{Na}_x\text{MoSe}_2$ , and then  $\text{Na}_x\text{MoSe}_2$  is converted to  $\text{Mo}$  and  $\text{Na}_2\text{Se}$ . The peaks ( $0.63 \text{ V}$ ,  $0.36 \text{ V}$ ) respectively stand for the alloying of amorphous Si and the development of a solid electrolyte interface (SEI) layer.<sup>46</sup> These two peaks vanished during the second cycle, resulting in an initial irreversible high capacity. Furthermore, during the charging process, two anodic peaks appeared at  $1.73 \text{ V}$  and  $2.0 \text{ V}$ . The peak ( $1.73 \text{ V}$ ) represents the process in which  $\text{Mo}$  is partially oxidized to  $\text{MoSe}_2$  and  $\text{Na}_2\text{Se}$  is partially converted to  $\text{Se}$ . Meanwhile, the peak ( $2.0 \text{ V}$ ) is due to the dealloying of Si.

From the *ex situ* TEM images of  $\text{C@SiO}_x/\text{MoSe}_2\text{-}3:1\text{@NMWCNT}$  (Fig. S14a, b and S15b†), When charged to either  $3 \text{ V}$  or  $2 \text{ V}$ , the spacing between lattice layers, matching the (004) plane of  $\text{MoSe}_2$ , measured approximately  $0.33 \text{ nm}$ . Additionally, the concentration of Se (Fig. S14j†) further confirmed the presence of Se. From the second cycle, the main cathodic peak at  $1.38 \text{ V}$  is a result of further insertion

of  $\text{Na}^+$ . In addition, from the second cycle onwards, the cyclic voltammetry (CV) curve remains nearly overlapping, signifying the material's stability when charged and discharged. Fig. 5b shows the galvanostatic charge and discharge profiles (at  $0.1 \text{ A g}^{-1}$ ) of the material  $\text{C@SiO}_x/\text{MoSe}_2\text{-}3:1\text{@NMWCNT}$  as an SIB electrode. The first discharge and charge capacities were  $1178$  and  $649 \text{ mA h g}^{-1}$ , respectively, with a charge/discharge efficiency of  $55\%$  in the first cycle. The low efficiency of the initial charge–discharge process can be attributed to the formation of an SEI layer during the first cycle. The charge/discharge efficiency rapidly increased to  $88.7\%$  in the second cycle and continued to exceed  $95\%$  in subsequent cycles, indicating the excellent reversibility of the  $\text{C@SiO}_x/\text{MoSe}_2\text{-}3:1\text{@NMWCNT}$  anode.

Fig. 5c shows the charge–discharge ratio capacity and cycle durability of the material  $\text{C@SiO}_x/\text{MoSe}_2\text{@NMWCNT}$  at  $1:1$ ,  $2:1$ ,  $3:1$ ,  $4:1$ , and  $5:1$  for  $\text{SiO}_x/\text{MoSe}_2$  (at  $0.5 \text{ A g}^{-1}$ , and the initial five cycles at  $0.1 \text{ A g}^{-1}$ ), and it is observable that the charge/discharge capacity is lower at  $1:1$ ,  $2:1$ ,  $4:1$ , and  $5:1$  for  $\text{SiO}_x/\text{MoSe}_2$ . At  $3:1$  for  $\text{SiO}_x/\text{MoSe}_2$ , superior charge–discharge capacity and enhanced cycle stability were achieved, with the discharge capacity remaining at  $526 \text{ mA h g}^{-1}$  even after 300 cycles.

As depicted in Fig. S16† the sodium-ion battery (SIB) electrode demonstrates significant capacitance attenuation and poor cycling stability without  $\text{SiO}_x$  or  $\text{NMWCNT}$  participation. For  $\text{C@MoSe}_2$ , after 300 cycles (at  $0.1 \text{ A g}^{-1}$ ), the discharge capacity decreases to  $99 \text{ mA h g}^{-1}$ . For  $\text{C@SiO}_x\text{@NMWCNT}$ , the incorporation of silicon leads to a growth in the initial capacity when charged and discharged. However, after five cycles, the specific capacity for charging and discharging began to decline, and over 300 cycles (at  $0.5 \text{ A g}^{-1}$ ), the average discharge capacity is approximately  $225 \text{ mA h g}^{-1}$ . For  $\text{C@SiO}_x/\text{MoSe}_2\text{@C}$ , after 300 cycles (at  $0.5 \text{ A g}^{-1}$ ), the discharge-specific capacity drops to  $378 \text{ mA h g}^{-1}$ , indicating poor cycling stability. These results indicate that the three-layer  $\text{C@SiO}_x/\text{MoSe}_2\text{-}3:1\text{@NMWCNT}$  heterojunction material exhibits an elevated specific capacity for charging and discharging and good cycle stability. Among them,  $\text{SiO}_x$  and  $\text{MoSe}_2$  exhibit the best battery performance when added at a ratio of  $3:1$  ( $\text{C@SiO}_x/\text{MoSe}_2\text{-}3:1\text{@NMWCNT}$ ). Their TEM, SEM and thermogravimetric analyses revealed that  $\text{SiO}_x/\text{MoSe}_2$  had more exposed edges and concentrations, providing more active sites when  $\text{C@SiO}_x/\text{MoSe}_2$  was grown on  $\text{NMWCNT}$ , thereby enhancing the specific capacity and stability over multiple cycles.

Fig. 5d illustrates the rate performance of the  $\text{C@SiO}_x/\text{MoSe}_2\text{-}3:1\text{@NMWCNT}$ , where a gradual decline in specific capacity is observed when the current density escalates from  $0.1$  to  $10 \text{ A g}^{-1}$ . When the current densities were  $0.1$ ,  $0.2$ ,  $0.4$ ,  $0.8$ ,  $1.0$ ,  $1.5$ ,  $2.0$ ,  $3.0$ ,  $4.0$ ,  $5.0$  and  $10.0 \text{ A g}^{-1}$ , respectively, the respective discharge-specific capacities were  $720$ ,  $644$ ,  $588$ ,  $536$ ,  $516$ ,  $485$ ,  $464$ ,  $434$ ,  $410$ ,  $395$  and  $347 \text{ mA h g}^{-1}$ . Upon reverting the current density to  $0.1 \text{ A g}^{-1}$ , the discharge capacity recovers to  $660 \text{ mA h g}^{-1}$ , indicating favorable reversibility. Fig. 5e highlights



the exceptional durability of the C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT, exhibiting a remarkable capacity retention of 353 mA h g<sup>-1</sup> after 3000 cycles at a current density of 5 A g<sup>-1</sup>. Even at a higher current density of 10 A g<sup>-1</sup>, it demonstrated excellent cycling stability, retaining 177.79 mA h g<sup>-1</sup> after 3000 cycles. Compared with C@MoSe<sub>2</sub>, C@SiO<sub>x</sub>@NMWCNT, and C@SiO<sub>x</sub>/MoSe<sub>2</sub>@C, the C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT composites combine high-capacity SiO<sub>x</sub> with MoSe<sub>2</sub> to form SiO<sub>x</sub>/MoSe<sub>2</sub>, which is grown on NMWCNT to provide additional active locations for storing Na<sup>+</sup> and improve the capacity as SIB electrodes. Simultaneously, the application of a carbon layer mitigates the volume fluctuations of the composite material when charged and discharged, thereby enhancing its cyclic stability.

The SEM images (Fig. 6a and b) show the change in the electrode sheet thickness of the C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT composite as the SIB electrode before and after charging and discharging. The results show that the morphology of C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT remained stable after charging and discharging, the electrode sheet thickness increased from 17.8 μm to 20.9 μm on average, and the structure did not collapse significantly. This proves that the unique three-layer heterojunction structure of the C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT composites buffers the volume changes when charged and discharged, thereby boosting the stability of the C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT composites and their durable cycling performance as SIB electrode materials.

The modifications made to silicon used as an anode material for SIBs are presented in Table 1. These include carbon coating, elemental doping, porous structure and composite material preparation. Although the volume expansion problem of silicon has been solved somewhat, the capacity is still not only satisfactory, so we try to synthesize the composite C@SiO<sub>x</sub>/MoSe<sub>2</sub>@NMWCNT by adding high-capacity SiO<sub>x</sub> into MoSe<sub>2</sub>, which has a two-dimensional structure, so that the lamellar structure of MoSe<sub>2</sub> relieves the volume expansion brought by SiO<sub>x</sub> along with mutually improving the overall capacity, and NMWCNT can also provide good electrical conductivity. Compared to their work, our three-layer C@SiO<sub>x</sub>/MoSe<sub>2</sub>@NMWCNT composite exhibits not only superior structural stability but also higher capacity. This enhancement was attributed to the excellent dispersion of SiO<sub>x</sub> facilitated by the layered MoSe<sub>2</sub> nanosheets. These

nanosheets provide abundant active sites, ensuring the uniform dispersion of high-capacity SiO<sub>x</sub> and preventing its aggregation during cycling. Therefore, when the C@SiO<sub>x</sub>/MoSe<sub>2</sub>@NMWCNT with a three-layer heterojunction structure is used for the anode of SIBs, it exhibits excellent charging and discharging performance with high discharge capacity and good stability performance.

The capacitance contribution of the C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT composites was studied based on their CV data, and Fig. 7a shows the CV curves of the C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT over a range of 0.2–1.2 mV s<sup>-1</sup> scan velocity. The *b* value at the anode (cathode) peak can be determined based on the correlation involving *i* and *v*, as shown in eqn (2) and (3):

$$i = a \times v^b \quad (2)$$

$$\log(i) = \log(a) + b \times \log(v) \quad (3)$$

As shown in Fig. 7b, the *b*-values of C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT composites at the anode and cathode are 0.96 and 0.86. It implies that this belongs to the pseudocapacitance process when the *b*-value is near 1.<sup>46</sup> The capacitance contribution ratio of C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT can be analyzed using eqn (4):

$$i(v) = k_1 v + k_2 v^{0.5} \quad (4)$$

In eqn (4), *k*<sub>1</sub>*v* and *k*<sub>2</sub>*v*<sup>0.5</sup> represent the capacitance-controlled behavior and diffusion-controlled behavior, respectively. According to Fig. 7c and d, when the scan speeds were 0.2 and 1.2 mV s<sup>-1</sup>, the capacitance contributions were 65% and 82%, respectively. As shown in Fig. 7e, the capacitance contribution rates are 65%, 71%, 75%, 78%, 80% and 82% at scanning speeds ranging from 0.2 to 1.2 mV s<sup>-1</sup>, which is in an increasing trend. These results confirm that the capacitive control process significantly contributes to the total capacity of the electrode at elevated scan rates.

The electrical and chemical interactions of the C@MoSe<sub>2</sub>, C@SiO<sub>x</sub>@NMWCNT, C@SiO<sub>x</sub>/MoSe<sub>2</sub>@C, C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT, C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT-1484 cycle, and C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT-2116 cycle materials underwent analysis *via* electrochemical impedance spectroscopy (Fig. 7f). The Nyquist plots comprise a semicircle in the high-frequency range, which is indicative of the charge transfer impedance (*R*<sub>ct</sub>) between the electrode and the electrolyte, along with a low-frequency area that represents the sodium diffusion impedance (*Z*<sub>w</sub>). In Fig. 7f, the *R*<sub>cts</sub> for the C@MoSe<sub>2</sub>, C@SiO<sub>x</sub>@NMWCNT, C@SiO<sub>x</sub>/MoSe<sub>2</sub>@C, C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT, C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT-1484 cycle, and C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT-2116 cycle are 107, 359, 204, 212, 328, and 492 Ω, respectively. The results indicate that the incorporation of NMWCNT elevates the charge transfer impedance, suggesting a robust interaction

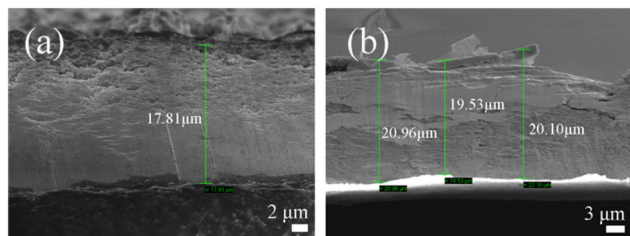


Fig. 6 *In situ* SEM thickness analysis images of C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT: (a) charge from open-circuit voltage 0.01 V to 3 V, (b) discharge from open-circuit voltage 3 V to 0.01 V.



**Table 1** Comparison with other Si/SiO<sub>x</sub> anode materials for SIBs

| Anode material                                | Synthesis method                           | Rate performance                                                                                       | Long-cycle performance                                                                                                      | Ref.      |
|-----------------------------------------------|--------------------------------------------|--------------------------------------------------------------------------------------------------------|-----------------------------------------------------------------------------------------------------------------------------|-----------|
| SiO <sub>x</sub> /C                           | Annealing                                  | 530 mA h g <sup>-1</sup> @0.03 A g <sup>-1</sup> ,<br>300 mA h g <sup>-1</sup> @0.1 A g <sup>-1</sup>  | 200 mA h g <sup>-1</sup> @0.3 A g <sup>-1</sup> , 100 cycles                                                                | 47        |
| Sn/SiO <sub>x</sub>                           | Jet milling                                |                                                                                                        | 340 mA h g <sup>-1</sup> @0.05 A g <sup>-1</sup> , 100 cycles                                                               | 32        |
| 2D Si-Ge                                      | Ball milling, annealing                    | 540 mA h g <sup>-1</sup> @0.05 A g <sup>-1</sup> ,<br>130 mA h g <sup>-1</sup> @2 A g <sup>-1</sup>    | 276 mA h g <sup>-1</sup> @0.05 A g <sup>-1</sup> , 50 cycles                                                                | 48        |
| Si/TiO <sub>2-x</sub> @C                      | Annealing                                  | 365.4 mA h g <sup>-1</sup> @0.1 A g <sup>-1</sup> ,<br>233.3 mA h g <sup>-1</sup> @2 A g <sup>-1</sup> | 191 mA h g <sup>-1</sup> @2 A g <sup>-1</sup> , 2500 cycles                                                                 | 28        |
| Si@MnSe@PPyC/rGO                              | Chemical bath deposition,<br>freeze-drying | 313 mA h g <sup>-1</sup> @0.1 A g <sup>-1</sup> ,<br>226.4 mA h g <sup>-1</sup> @2 A g <sup>-1</sup>   | 323 mA h g <sup>-1</sup> @0.2 A g <sup>-1</sup> , 270 cycles                                                                | 31        |
| C@SiO <sub>x</sub> /MoSe <sub>2</sub> @NMWCNT | Annealing                                  | 720 mA h g <sup>-1</sup> @0.1 A g <sup>-1</sup> ,<br>347 mA h g <sup>-1</sup> @10 A g <sup>-1</sup>    | 415 mA h g <sup>-1</sup> @5 A g <sup>-1</sup> , 1000 cycles,<br>353 mA h g <sup>-1</sup> @5 A g <sup>-1</sup> , 3000 cycles | This work |

between SiO<sub>x</sub>/MoSe<sub>2</sub> and NMWCNT. When C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT was used as the electrode material, the  $R_{ct}$  increased only significantly after 2116 cycles, suggesting that the material exhibited excellent cycling stability.

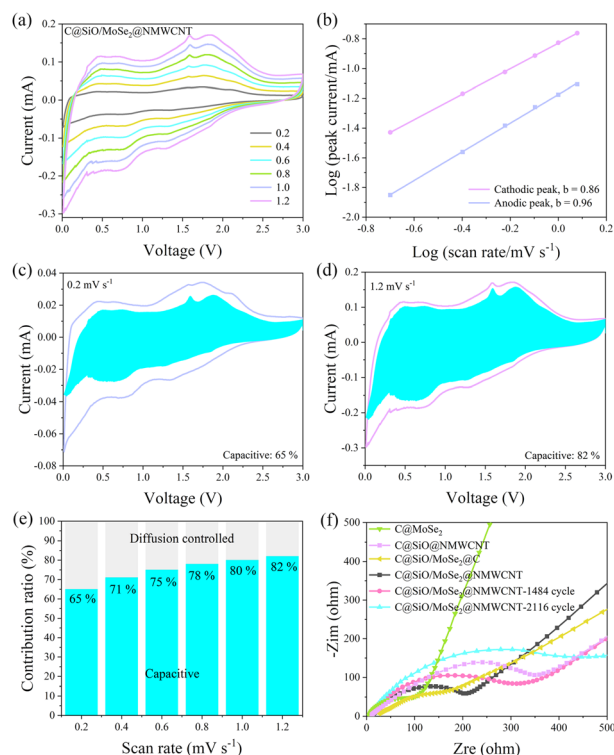
Fig. 8a shows the Nyquist plots for the C@MoSe<sub>2</sub>, C@SiO<sub>x</sub>@NMWCNT, C@SiO<sub>x</sub>/MoSe<sub>2</sub>@C, C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT, C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT-1484 cycle, and C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT-2116 cycle, used for calculating the sodium diffusion coefficient ( $D$ ) according to eqn (5):

$$D = R^2 T^2 / 2A^2 n^4 F^4 C^2 \sigma^2 \quad (5)$$

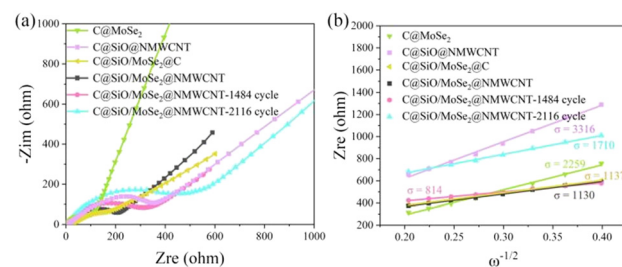
where  $R$  is the gas constant,  $T$  represents the absolute temperature,  $A$  denotes the contact area between the electrolyte and the active material,  $n$  is the number of electrons transferred during the deintercalation of sodium,  $F$  represents the Faraday constant, and  $C$  is the concentration of Na<sup>+</sup>. The value of  $\sigma$  can be calculated from eqn (6):

$$Z_{\text{real}} = R_e + R_{ct} + \sigma \omega^{-1/2} \quad (6)$$

where  $R_e$  is the resistance between the electrolyte and electrode,  $R_{ct}$  represents the charge transfer resistance, and  $\omega$  denotes the angular frequency. Fig. 8b illustrates the relationship between  $Z_{\text{real}}$  and  $\omega^{-1/2}$ , from which the slope  $\sigma$  can be obtained. The  $\sigma$  of C@MoSe<sub>2</sub>, C@SiO<sub>x</sub>@NMWCNT, C@SiO<sub>x</sub>/MoSe<sub>2</sub>@C, C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT, C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT-1484 cycle, and C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT-2116 cycle were calculated to be 4.130787205996194 × 10<sup>-18</sup> cm<sup>2</sup> s<sup>-1</sup>, 1.917062364763804 × 10<sup>-18</sup> cm<sup>2</sup> s<sup>-1</sup>, 1.63058842731859 × 10<sup>-17</sup> cm<sup>2</sup> s<sup>-1</sup>,



**Fig. 7** (a) CV curves of C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT, (b) curves of log (scan rate) versus log (peak current), (c) and (d) Pseudocapacitive contribution of C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT (0.2 & 1.2 mV s<sup>-1</sup>), (e) Pseudocapacitive contribution of C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT, (f) Nyquist plots of C@MoSe<sub>2</sub>, C@SiO<sub>x</sub>@NMWCNT, C@SiO<sub>x</sub>/MoSe<sub>2</sub>@C, C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT, C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT-1484 cycle and C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT-2116 cycle.



**Fig. 8** (a) Nyquist plots of the C@MoSe<sub>2</sub>, C@SiO<sub>x</sub>@NMWCNT, C@SiO<sub>x</sub>/MoSe<sub>2</sub>@C, C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT, C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT-1484 cycle and C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT-2116 cycle, and (b) functional relation diagrams of  $Z_{\text{real}}$  and  $\omega^{-1/2}$ .



$1.650852980340063 \times 10^{-17} \text{ cm}^2 \text{ s}^{-1}$ ,  $3.18138680371784 \times 10^{-17} \text{ cm}^2 \text{ s}^{-1}$ ,  $7.208967445012913 \times 10^{-18} \text{ cm}^2 \text{ s}^{-1}$ . This indicates that the sodium-ion mobility of the C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT is stronger than that of the C@MoSe<sub>2</sub>, C@SiO<sub>x</sub>@NMWCNT and C@SiO<sub>x</sub>/MoSe<sub>2</sub>@C. More interestingly, the sodium-ion mobility of the C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT composites after 1484 cycles was higher than that before cycling. The C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT composites were further validated for their exceptional performance and robust cycling stability.

## Conclusions

In summary, we describe a straightforward method for synthesizing C@SiO<sub>x</sub>/MoSe<sub>2</sub>@NMWCNT three-layer heterojunction materials based on NMWCNTs. The three-layer heterojunction structure within the composite system is capable of not only efficiently accommodating the volume fluctuations of SiO<sub>x</sub>/MoSe<sub>2</sub> but also preserving the structural stability of the electrode, thereby improving the conductivity of sodium ions and electrons, but also making the high-capacity SiO<sub>x</sub> uniformly dispersed in the MoSe<sub>2</sub> nanosheet framework. When used as a stand-alone electrode, the optimized C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT material provides high capacity (526 mA h g<sup>-1</sup> after 300 cycles at 500 mA g<sup>-1</sup>) and robust cycling stability (373 mA h g<sup>-1</sup> after 2000 cycles at 5A g<sup>-1</sup> and 353 mA h g<sup>-1</sup> after 3000 cycles, 177.79 mA h g<sup>-1</sup> after 3000 cycles at 10 A g<sup>-1</sup>). The good characteristics of this composite can be attributed to these underlying factors. First, high-capacity silicon was added to the composite system, and the two-dimensional (2D) MoSe<sub>2</sub> nanoflap played the role of dispersing silicon, which improved the discharge capacity and rate performance of the C@SiO<sub>x</sub>/MoSe<sub>2</sub>@NMWCNT composites. The second is the formation of three-dimensional heterojunction materials, NMWCNT and externally coated carbon, which provide a specific space for SiO<sub>x</sub>/MoSe<sub>2</sub>, which can alleviate the volume expansion caused by the detachment and intercalation of Na<sup>+</sup> and increase the cyclic durability of the composites. The newly devised synthesis technique can be used to design electrode materials intended for the fabrication of SIBs.

## Experimental

### Materials and methods

**Preparation of the C@MoSe<sub>2</sub>, C@SiO<sub>x</sub>@NMWCNT, C@SiO<sub>x</sub>/MoSe<sub>2</sub>@C, and C@SiO<sub>x</sub>/MoSe<sub>2</sub>@NMWCNT anode materials.** The raw materials used include ethylene glycol, molybdenum pentachloride, selenium powder, triphenylchlorosilane, and NMWCNTs. All raw materials were purchased directly and do not require pre-treatment before use. Among them, NMWCNT was purchased from Xian Feng Nano Co.

First, ethylene glycol (15 mL) and MoCl<sub>5</sub> (27.2 mg) were mixed for four hours of sonication and then poured into a ceramic ark filled with Se (24 mg) and calcined to 800 °C in a

tube furnace to prepare C@MoSe<sub>2</sub> (12.37 mg). The yield of the anode material was 44% (based on Mo element), 33% (based on Se element).

As in the above process, ethylene glycol (15 mL) and triphenylchlorosilane (88.2 mg) were mixed to form a mixed solution (ultrasonic until completely dissolved). NMWCNTs (8 mg) were then added, and ultrasonication was continued for 4 h. Finally, this mixed solution was poured into a ceramic ark and calcined to 800 °C in a cylindrical furnace to prepare C@SiO<sub>x</sub>@NMWCNT (12.1 mg), and the yield of the anode material was 5.9% (based on Si element).

As above, MoCl<sub>5</sub> (27.2 mg) was first dissolved in ethylene glycol (8.5 mL), then triphenylchlorosilane (58.8 mg) and ethylene glycol (11.5 mL) were added to ultrasonic for four hours and then poured into the ceramic ark filled with Se (24 mg) and calcined to 800 °C in a cylindrical furnace to prepare C@SiO<sub>x</sub>/MoSe<sub>2</sub>@C (26.4 mg); the yield of anode material was 91% (based on Mo element), 66% (based on Se element), and 7.8% (based on Si element).

In the same way, when SiO<sub>x</sub> and MoCl<sub>5</sub> were in different proportions (1:1, 2:1, 3:1, 4:1, 5:1), MoCl<sub>5</sub> (27.2 mg) was first separately dissolved in a certain amount of ethylene glycol (10 mL, 8.5 mL, 5.6 mL, 6 mL, 6 mL), then different amounts of triphenylchlorosilane (29.4 mg, 58.8 mg, 88.2 mg, 117.6 mg, 147 mg) and ethylene glycol (5.6 mL, 11.5 mL, 17 mL, 20 mL, 22 mL) were separately added to ultrasonic for four hours and then poured into the ceramic ark filled with Se (24 mg) and calcined to 800 °C in a tube furnace to prepare C@SiO<sub>x</sub>/MoSe<sub>2</sub>@NMWCNT (32 mg, 29.06 mg, 33.9 mg, 29.86 mg, 33.89 mg). The composites obtained with different ratios of SiO<sub>x</sub> and MoCl<sub>5</sub> were respectively named C@SiO<sub>x</sub>/MoSe<sub>2</sub>-1:1@NMWCNT, C@SiO<sub>x</sub>/MoSe<sub>2</sub>-2:1@NMWCNT, C@SiO<sub>x</sub>/MoSe<sub>2</sub>-3:1@NMWCNT, C@SiO<sub>x</sub>/MoSe<sub>2</sub>-4:1@NMWCNT and C@SiO<sub>x</sub>/MoSe<sub>2</sub>-5:1@NMWCNT. When the ratio was 3:1, the yield of anode material is 77% (based on Mo element), 57% (based on the Se element), and 10% (based on the Si element).

The tube furnace was first heated for 2 h at 80 °C, then heated for 3 h at 180 °C, and finally heated for 4 h at 800 °C. The heating conditions are: heating rate of 5 °C min<sup>-1</sup> and Ar heating atmosphere.

### Material characterization

The scanning electron microscope SEM (S-4800 & IGMAMD) and transmission electron microscope TEM (JEM-2100F) were used to observe the morphology of the materials. The structure of the substance was observed by X-ray photoelectron spectroscopy AXIS SUPRA (SHIMADZU), X-ray powder diffraction with Bruker-D8 and Raman spectra Lab RAM Odyssey (HORIBA). The MoSe<sub>2</sub> and SiO<sub>x</sub> contents were measured by thermogravimetry (STA7200 HITACHI).

### Fabrication of cells and electrochemical measurements.

Initially, C@MoSe<sub>2</sub>, C@SiO<sub>x</sub>@NMWCNT, C@SiO<sub>x</sub>/MoSe<sub>2</sub>@C, or C@SiO<sub>x</sub>/MoSe<sub>2</sub>@NMWCNT are blended with carboxyl



methyated cellulose and carbon black, each in a mass ratio of 4:1:1. Then, a suitable quantity of deionized water and ethanol was added and stirred to produce a mixed slurry. Finally, the slurry was evenly applied to the copper foil. Subsequently, it was dried inside a vacuum oven used for drying and then cut to obtain electrode sheets. The electrode sheets, electrolyte, separator, sodium metal and CR2032 coin cells were then assembled into batteries. Sodium-ion batteries are made in a glove box with an Ar atmosphere, and the concentration of water and oxygen within the glove box should be less than 0.5 ppm. The electrolyte consisted of 1 M NaClO<sub>4</sub> dissolved in a mixture with a 1:1 EC/PC volume ratio containing 5% FEC and a fiberglass separator. After assembling the batteries, they were tested for cycling and rate performance using the Neware test system with a voltage range of 0.01–3.0 V (vs. Na<sup>+</sup>/Na), and a range of current densities was employed during the testing process. Cyclic voltammetry (CV) and alternating current impedance (AC-Impedance) measurements were performed using a CH Instrument model CHI 660E.

## Data availability

The data supporting this article are included in the ESI.†

## Author contributions

Conceptualization: RQ, MB, YY, YC, WD; methodology: RQ, MB, YY, TW, YC, WD; investigation: MB, YY, TW, BF, YC; project administration: RQ; writing – original draft: RQ, MB; writing – review & editing: RQ, MB, YY, YC, WD.

## Conflicts of interest

MB and YY contribute equally.

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